

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BYRNE ET AL.	
		Examiner Hung T Vy	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,331,838 B1	12-2001	Scott et al.	343/715
	B	US-6,809,686 B2	10-2004	Du et al.	343/700MS
	C	US-5,757,327 A	05-1998	Yajima et al.	343/713
	D	US-6,788,264 B2	09-2004	Du, Xin	343/725
	E	US- 2004/0251307	12-2004	Schmidh et al.	235/462.46
	F	US-6,283,375 B1	09-2001	Wilz et al.	235/462.45
	G	US-2002/0057792 A1	05-2002	FUHRMANN et al.	379/419
	H	US-2003/0138097 A1	07-2003	Fuhrmann et al.	379/428.01
	I	US-2004/0017314 A1	01-2004	Petropolous, Athanasios	343/700.0MS
	J	US-6,773,652 B2	08-2004	Loy et al.	264/274
	K	US-4,728,962	03-1988	Kitsuda et al.	343/872
	L	US-5,568,157 A	10-1996	Anderson, Philip M.	343/713
	M	US-2003/0193440 A1	10-2003	Yang, A Sheng	343/711

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.